## Notice of References Cited Application/Control No. 10/553,506 Applicant(s)/Patent Under Reexamination WEIBERLE ET AL. Examiner Bryce P. Bonzo 2113 Applicant(s)/Patent Under Reexamination WEIBERLE ET AL.

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,504,859 A	04-1996	Gustafson et al.	714/11
*	В	US-5,898,829 A	04-1999	Morikawa, Takahiro	714/47
*	C	US-6,065,135 A	05-2000	Marshall et al.	714/11
*	D	US-2003/0182594 A1	09-2003	Watkins et al.	714/11
*	Е	US-6,640,313 B1	10-2003	Quach, Nhon	714/10
*	F	US-2004/0153763 A1	08-2004	Grochowski et al.	714/017
*	G	US-6,820,213 B1	11-2004	Somers et al.	714/11
*	Η	US-2006/0085677 A1	04-2006	Safford et al.	714/011
	-	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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